The rate of escape for random walks on solvable groups

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- G can be viewed as a (length) metric space $(G, |\cdot|_G)$, which is the Cayley graph of G with respect to S.
- Changing generating sets gives equivalent metrics on G and quasi-isometric Cayley graphs.

Let μ be a probability measure on G. We will assume that μ is symmetric $(\mu(g) = \mu(g^{-1})$ for all $g \in G$), and supported on a finite generating set of G.

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A random walk, X_n , on G whose increments are distributed according to such a measure is said to be simple and symmetric. In particular, $X_n = ex_1x_2\cdots x_n$ where x_i is the *i*th increment of the random walk.

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- We say a random walk has escape exponent α if $\exists c > 0$ such that $\frac{1}{c}n^{\alpha} \leq \mathbb{E}_{\mu^{(n)}}|X_n|_G \leq cn^{\alpha}$ for all $n \geq 1$.

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- One can also consider a law of the iterated logarithm: $\limsup_{n\to\infty} \frac{|X_n|_G}{\sqrt{n^{\alpha}\log\log n}} \in (0,\infty) \text{ a.s with respect to } \mu.$

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Big question: On a given group does the escape exponent of a simple symmetric random walk depend on the choice of finite generating set?

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- Nilpotent groups: $\alpha = 1/2$ for all simple symmetric random walks (Hebisch, Saloff-Coste),
- Non-amenable groups: $\alpha = 1$ for all simple symmetric random walks (classical).
- Outside of these classes the escape exponent is known only on particular groups and only for particular families of measures (Revelle, Erschler).

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Suppose the random walk, $X_n = (W_n, Y_n)$, on G has increments $x_i = (w_i, y_i)$. Then

$$X_n = (\prod_{i=1}^n \phi^{Y_{i-1}} w_i, Y_n).$$

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Observe that $|Y_n|_G = |Y_n|_K$, but the story is more complicated for W_n .

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A finitely generated subgroup H of G is said to be *strictly exponentially distorted* if there exists a c > 0 such that

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Examples: Sol; BS(1, n), n = 1.

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Let $G = H \rtimes_{\phi} \mathbb{Z}^d$. If H is finitely generated and strictly exponentially distorted in G, then for any simple symmetric random walk $X_n = (W_n, Y_n)$ on G there exists C > 0 such that

 $\mathbb{E}_{\mu^{(n)}} |Y_n|_G \le \mathbb{E}_{\mu^{(n)}} |X_n|_G \le C(\mathbb{E}_{\mu^{(n)}} \max_{i < n} |Y_n|_G + \mathbb{E}_{\mu^{(n)}} |Y_n|_G + \log n)$

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Corollary

Under the above hypotheses, G has escape exponent 1/2 for all simple symmetric random walks.

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Under the above hypotheses, G has escape exponent 1/2 for all simple symmetric random walks.

Example: $\mathbb{Z}^2 \rtimes_{\phi} \mathbb{Z}, |tr(\phi)| > 2.$

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Let $G = H \rtimes_{\phi} \mathbb{Z}^d$ be finitely generated. Fix a generating set S of G. If $\pi_H(S)$ generates a strictly exponentially distorted subgroup of G, then for any symmetric random walk supported on S there exists C > 0 such that

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Idea of the proofs.

Show that for all $z \in \mathbb{Z}^d$, $h \in H$, there exists $q \ge 1$ such that $|\phi^z \cdot h|_H \le q^{|z|} |h|_H$. Then use strictly exponential distortion to bring this estimate into $|\cdot|_G$.

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